

Temperature- and Pressure-dependent X-ray Diffraction on A-site Doped Lead Scandium Niobate

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High-resolution powder and synchrotron-based single crystal X-ray diffraction studies in a wide temperature range on the A-site doped perovskite-type relaxor-ferroelectrics $\text{Pb}_{1-x}\text{A}_x\text{Sc}_{0.51}\text{Nb}_{0.49}\text{O}_3$ ($\text{A}_x = \text{Ba}_{0.07}, \text{Bi}_{0.06}$) are presented. The temperature evolution of the pseudo-cubic lattice parameter reveal structural phase transformations near 450-550 K associated with coupling of polar nano-regions (PNR).

Further, pressure-induced structural changes are compared to the temperature-driven phase transformations. High pressure single crystal X-ray diffraction analysis was applied at room temperature in the pressure range up to 8 GPa. The pressure dependence of the volume compressibility reveals structural phase transformations around 4 GPa in both compounds due to a pressure-induced decrease in the correlation length of PNR.

Complementary polarized Raman spectroscopy data in the same temperature and pressure range will be presented to complete the structural picture on a local scale.

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